

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/597,856	LEE, KEUN-JIN	
Examiner		Art Unit		Page 1 of 1
Hal I. Kaplan		2836		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,424,903	06-1995	Schreiber, Paul T.	361/166
*	B	US-5,483,464	01-1996	Song, Moon-Jong	713/300
*	C	US-5,506,790	04-1996	Nguyen, Sanh K.	700/286
*	D	US-5,721,934	02-1998	Scheurich, Christoph E.	713/320
*	E	US-6,573,619	06-2003	Chin, Yi-Ho	307/125
*	F	US-6,670,597	12-2003	Kitamura et al.	250/214AL
*	G	US-6,731,024	05-2004	Molnar et al.	307/147
*	H	US-6,940,272	09-2005	Niv, Nehemia	324/158.1
*	I	US-7,043,543	05-2006	Ewing et al.	709/223
*	J	US-7,151,234	12-2006	Wolpert et al.	200/51.09
*	K	US-7,193,335	03-2007	Palmer et al.	307/39
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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